## Notice of References Cited Application/Control No. 10/642,622 Examiner Eric S. McCall Applicant(s)/Patent Under Reexamination TSUYUKI ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification		
	Α	US-2002/0193936	12-2002	Saito et al.	701/114		
	В	US-2002/0129643	09-2002	Yamaguchi et al.	73/49.7		
	С	US-6,651,631	11-2003	Hayashi et al.	123/520		
	D	US-					
	Е	US-					
	F	US-					
	G	US-					
	Ξ	US-					
	_	US-					
	J	US-					
	К	US-					
	L	US-					
	М	US-					

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
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	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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